Application/Control No. Applicant(s)/Patent Under Reexamination 09/753,326 KEDIA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2116 Tse Chen **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Umina et al. 711/120 US-5,287,485 02-1994 Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-

FOREIGN PATENT DOCUMENTS

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